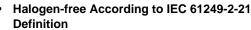


# SI1410EDH-T1-GE3-VB Datasheet N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS}(V)$ $R_{DS(on)}(\Omega)$		Q <sub>g</sub> (Typ.)			
30	0.023 at V <sub>GS</sub> = 10 V	4.5	4.2 nC			
	0.027 at V <sub>GS</sub> = 4.5 V	4.0	4.2110			

# **FEATURES**

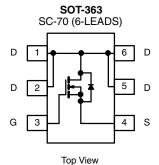




- Trench Power MOSFET
- Low On-Resistance
- 100 % R<sub>q</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

• DC/DC Converters, High Speed Switching



Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30	.,	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		4.5 <sup>e</sup>	
Continuous Proin Current (T. 150 °C)	T <sub>C</sub> = 70 °C		4.0 <sup>e</sup>	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	4.1 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		3.6 <sup>b, c</sup>	A
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	25	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	,	2.1	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	1.1 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		2.5	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		1.6	W
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.3 <sup>b, c</sup>	VV
	T <sub>A</sub> = 70 °C		0.8 <sup>b, c</sup>	
Operating Junction and Storage Temperatur	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	75	100	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	40	50	C/ V V		

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 166 °C/W.
- e. Package limited.



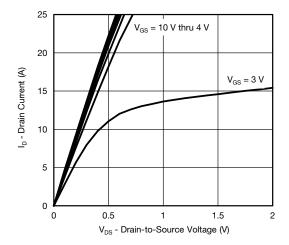
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	30			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		30		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 <sub>D</sub> = 230 μA		- 4.8		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.5		2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
7 0 1 1/1 5 1 0 1	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	μA
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α
Dunin Course On Chata Desistance	В	$V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$		0.023		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 3 \text{ A}$		0.027		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 3.5 \text{ A}$		24		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			424		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		100		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			42		
Total Gate Charge	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$		8.2	13	nC
				4.2	7	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 3.5 \text{ A}$		1.4		
Gate-Drain Charge	Q <sub>gd</sub>			1.4		
Gate Resistance	$R_g$	f = 1 MHz	2.5	12.6	25.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			6	12	- ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3.4 $\Omega$		20	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		14	21	
Fall Time	t <sub>f</sub>			10	20	
Turn-On Delay Time	t <sub>d(on)</sub>			3	6	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3.4 $\Omega$		11	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \approx 4.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		20	30	
Fall Time	t <sub>f</sub>			7	14	
<b>Drain-Source Body Diode Characteristi</b>	cs					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			2.1	А
Pulse Diode Forward Current	I <sub>SM</sub>				25	
Body Diode Voltage	V <sub>SD</sub>	$I_S = 4.4 \text{ A}, V_{GS} = 0 \text{ V}$		0.82	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			13	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 4.4 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C		6	12	nC
Reverse Recovery Fall Time	t <sub>a</sub>	1 4.4 Λ, αναι - 100 Ανμο, 1J = 25 C		8		
Reverse Recovery Rise Time	t <sub>b</sub>	t <sub>b</sub>		5		ns

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

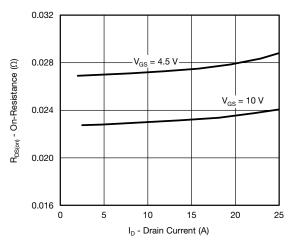
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



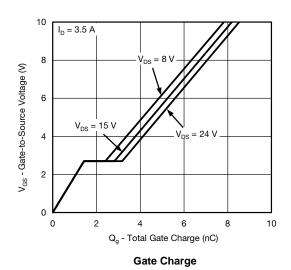
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



### **Output Characteristics**

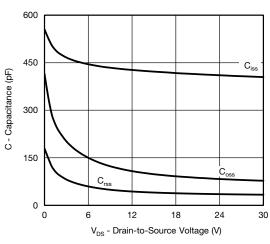


On-Resistance vs. Drain Current and Gate Voltage

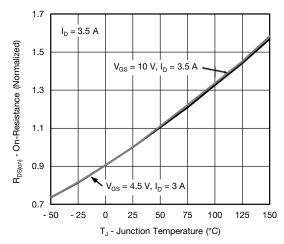


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**Transfer Characteristics** 



Capacitance

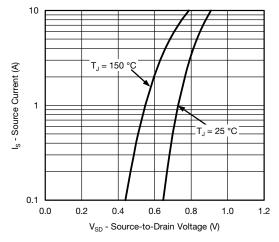


On-Resistance vs. Junction Temperature

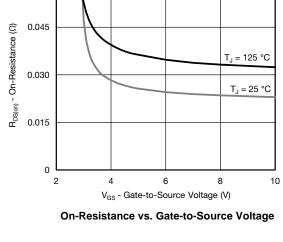


 $I_{D} = 5.5 A$ 

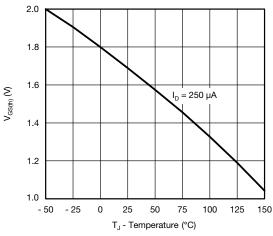
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### Source-Drain Diode Forward Voltage

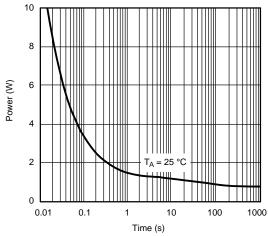


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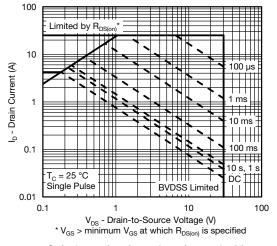


**Threshold Voltage** 

4



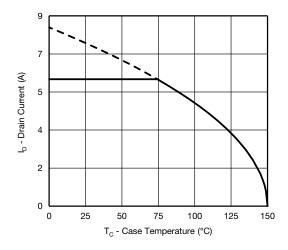
Single Pulse Power (Junction-to-Ambient)



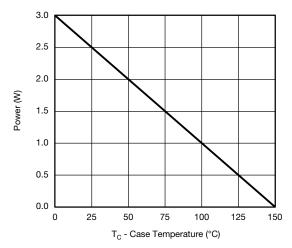
Safe Operating Area, Junction-to-Ambient



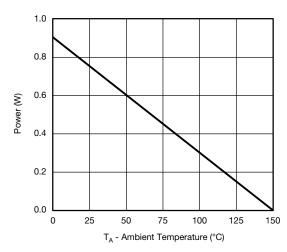
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***





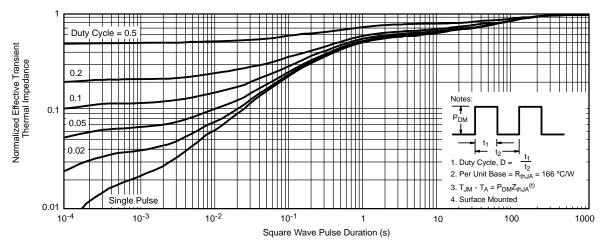


Power Derating, Junction-to-Ambient

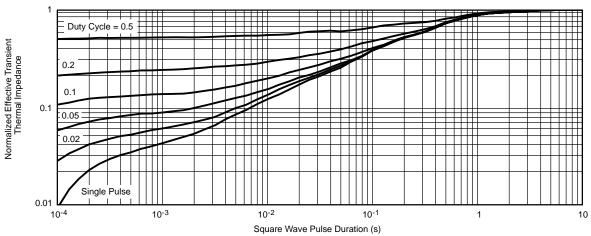
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



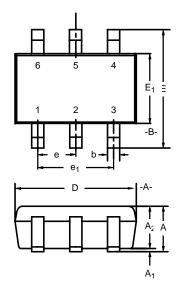
Normalized Thermal Transient Impedance, Junction-to-Ambient

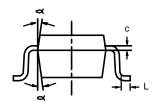


Normalized Thermal Transient Impedance, Junction-to-Foot



SC-70: 6-LEADS





	MIL	LIMET	ERS	INCHES		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.90	_	1.10	0.035	_	0.043
<b>A</b> <sub>1</sub>	_	_	0.10	-	_	0.004
A <sub>2</sub>	0.80	-	1.00	0.031	-	0.039
b	0.15	-	0.30	0.006	-	0.012
С	0.10	-	0.25	0.004	-	0.010
D	1.80	2.00	2.20	0.071	0.079	0.087
Ε	1.80	2.10	2.40	0.071	0.083	0.094
E <sub>1</sub>	1.15	1.25	1.35	0.045	0.049	0.053
е	0.65BSC			0.026BSC		
e <sub>1</sub>	1.20	1.30	1.40	0.047	0.051	0.055
L	0.10	0.20	0.30	0.004	0.008	0.012
a	7°Nom			7°Nom		
ECN: S-03946—Rev. B, 09-Jul-01						

DWG: 5550



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